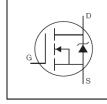


AUIRFR2905Z

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



V _{DSS}		55V
R _{DS(on)}	typ.	11.1mΩ
	max.	14.5mΩ
D (Silicon Lin	nited)	59A®
I _{D (Package L}	imited)	42A



	AUINI N29032	
G	D	S
Gate	Drain	Source

Description

Specifically designed for Automotive applications, this HEXFET[®] Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

Base part number	Baakaga Tupa	Standard Pack		Orderable Part Number	
	Package Type	Form	Quantity	Orderable Part Number	
AUIRFR2905Z	D-Pak	Tube	75	AUIRFR2905Z	
		Tape and Reel Left	3000	AUIRFR2905ZTRL	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	59 ⑨	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	429	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	42	A
I _{DM}	Pulsed Drain Current ①	240	
P _D @T _C = 25°C	Maximum Power Dissipation	110	W
	Linear Derating Factor	0.72	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) 2	55	
E _{AS} (Tested)	Single Pulse Avalanche Energy Tested Value 6	82	mJ
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	A
E _{AR}	Repetitive Avalanche Energy S		mJ
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{θJC}	Junction-to-Case ®		1.38	
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount) 🗇		50	°C/W
$R_{ ext{ heta}JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

*Qualification standards can be found at www.infineon.com



AUIRFR2905Z

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55		_	V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.053		V/°C	Reference to 25°C, I_D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		11.1	14.5	mΩ	V _{GS} = 10V, I _D = 36A ③
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	20			S	V _{DS} = 25V, I _D = 36A
R _G	Gate Input Resistance		1.3		Ω	f = 1.0 MHz , open drain
1	Drain to Source Lookage Current			20	uА	V _{DS} = 55 V, V _{GS} = 0V
DSS	Drain-to-Source Leakage Current 250 µA		μΑ	V _{DS} = 55V,V _{GS} = 0V,T _J =125°C		
1	Gate-to-Source Forward Leakage			200	n A	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-200	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

•	U	-			
Q _g	Total Gate Charge	 29	44		I _D = 36A
Q_{gs}	Gate-to-Source Charge	 7.7		nC	$V_{DS} = 44V$
Q _{gd}	Gate-to-Drain Charge	 12			V _{GS} = 10V③
t _{d(on)}	Turn-On Delay Time	 14			$V_{DD} = 28V$
t _r	Rise Time	 66			I _D = 36A
t _{d(off)}	Turn-Off Delay Time	 31		ns	R _G = 15Ω
t _f	Fall Time	 35			V _{GS} = 10V③
L _D	Internal Drain Inductance	 4.5		nH	Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance	 7.5			from package and center of die contact
C _{iss}	Input Capacitance	 1380			V _{GS} = 0V
C _{oss}	Output Capacitance	 240			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance	 120		pF	f = 1.0MHz
C _{oss}	Output Capacitance	 820		μr	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
C _{oss}	Output Capacitance	 190			$V_{GS} = 0V, V_{DS} = 44V f = 1.0MHz$
C _{oss eff.}	Effective Output Capacitance	 300			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 44V \oplus$
Diode Charact	eristics	 			

	Parameter	Min.	Тур.	Max.	Units	Conditions	
ls	Continuous Source Current (Body Diode)			429		MOSFET symbol showing the	
I _{SM}	Pulsed Source Current (Body Diode) ①			240		integral reverse	
V_{SD}	Diode Forward Voltage			1.3	V	T _J = 25°C,I _S = 36A,V _{GS} = 0V ③	
t _{rr}	Reverse Recovery Time		23	35	ns	T _J = 25°C ,I _F = 36A, V _{DD} = 28V	
Q _{rr}	Reverse Recovery Charge		16	24	nC	di/dt = 100A/µs③	
t _{on}	Forward Turn-On Time	Intrinsic	Intrinsic turn-on time is negligible (turn-on is dominated by L _s +L _D)				

Notes:

 $\odot\;$ Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

Limited by T_{Jmax}, starting T_J = 25°C, L = 0.08mH, R_G = 25Ω, I_{AS} = 36A, V_{GS} = 10V. Part not recommended for use above this value.
 Pulse width ≤ 1.0ms; duty cycle ≤ 2%.

④ Coss eff. is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS

© Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

© This value determined from sample failure population. 100% tested to this value in production.

When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

 $\label{eq:rescaled} \ \ \, R_{\theta} \ \, \text{is measured at } T_J \ \, \text{approximately } 90^{\circ}\text{C}$

Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 42A.



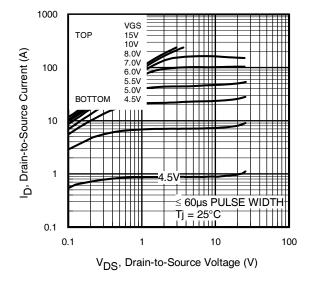


Fig. 1 Typical Output Characteristics

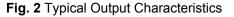
I_D, Drain-to-Source Current (A) 6.0V 5.5V 100 5.0V BOTTOM 4.5V 10 ≤ 60µs PULSE WIDTH Tj = 175°C 1 0.1 1 10 100 V_{DS}, Drain-to-Source Voltage (V)

VGS 15V 10V

8.0V 7.0V

1000

тор



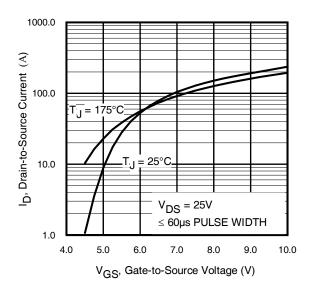


Fig. 3 Typical Transfer Characteristics

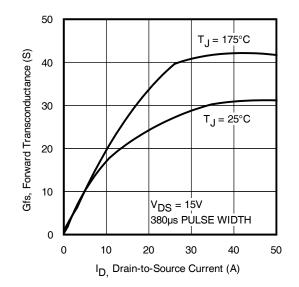
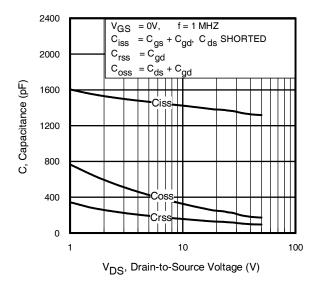
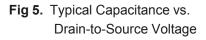


Fig. 4 Typical Forward Transconductance Vs. Drain Current







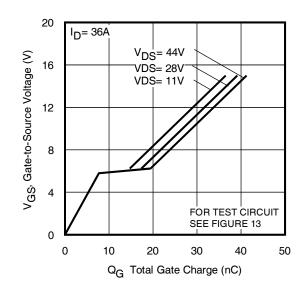


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

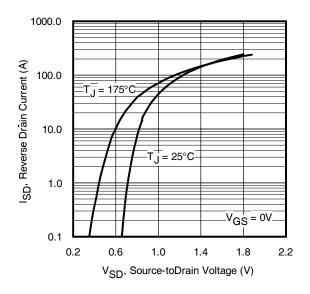


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

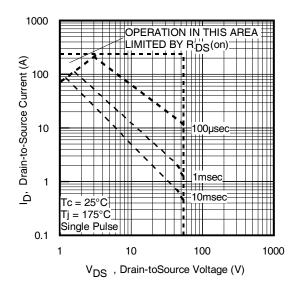
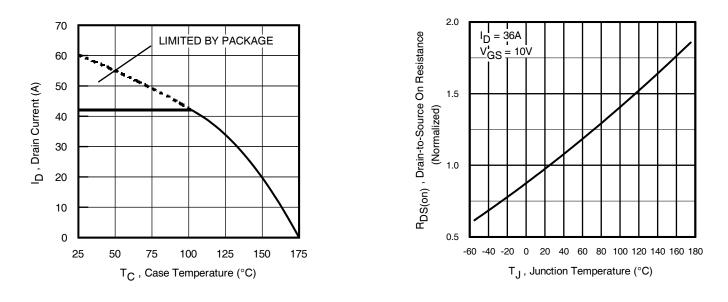
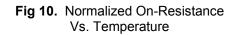


Fig 8. Maximum Safe Operating Area









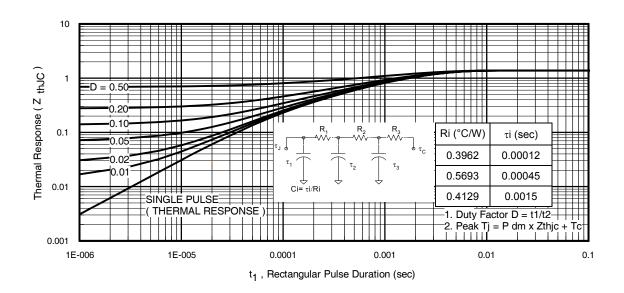


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

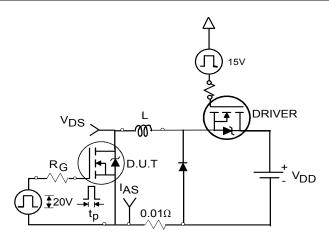


Fig 12a. Unclamped Inductive Test Circuit

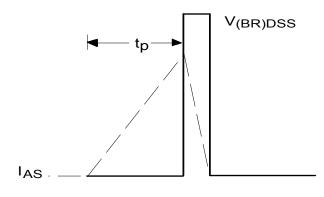


Fig 12b. Unclamped Inductive Waveforms

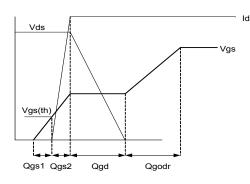


Fig 13a. Gate Charge Waveform

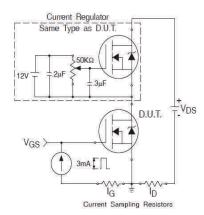
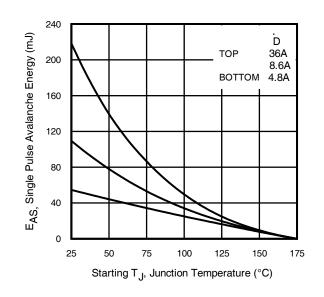
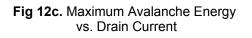


Fig 13b. Gate Charge Test Circuit





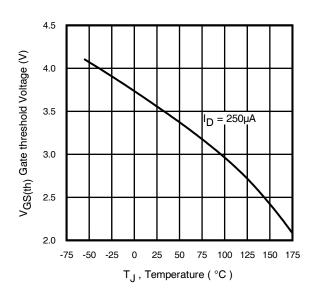


Fig 14. Threshold Voltage Vs. Temperature



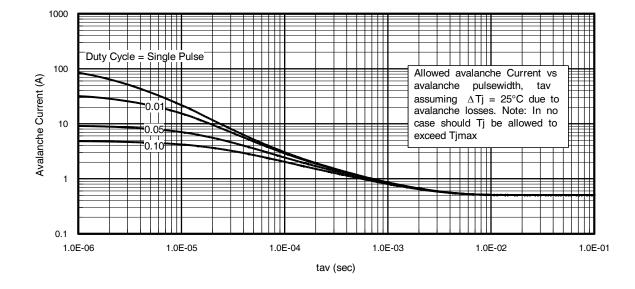
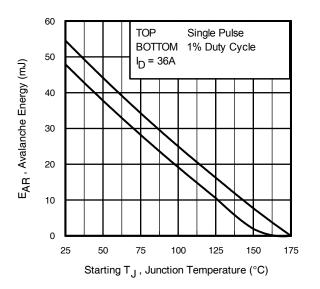
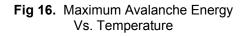


Fig 15. Typical Avalanche Current Vs. Pulse width





Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} \textbf{P}_{D (ave)} &= 1/2 \; (\; 1.3 \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T / \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2 \Delta T / \; \textbf{[} 1.3 \cdot \textbf{BV} \cdot \textbf{Z}_{th} \textbf{]} \\ \textbf{E}_{AS (AR)} &= \textbf{P}_{D (ave)} \cdot \textbf{t}_{av} \end{split}$$



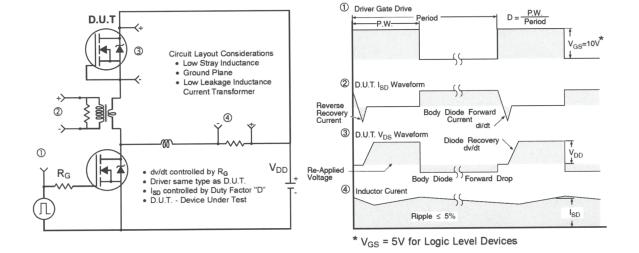


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

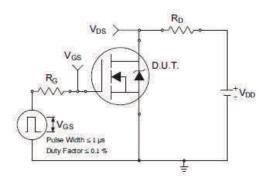


Fig 18a. Switching Time Test Circuit

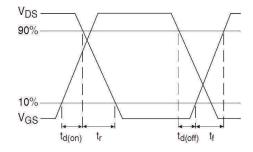
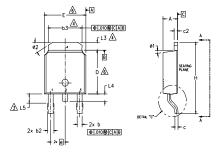


Fig 18b. Switching Time Waveforms

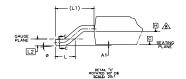


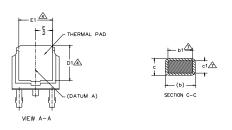
AUIRFR2905Z

D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & 63 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ▲ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- A- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

9	OUTLINE	CONFORMS	TO	JEDEC	OUTLINE	TO-252AA.	

S Y		DIMEN	SIONS		N
M B O	MILLIM	ETERS	INC	HES	0 T E S
0 L	MIN.	MAX.	MIN.	MAX.	E S
Α	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
b	0.64	0.89	.025	.035	
ь1	0.65	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
с	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Е	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
е	2.29	BSC	.090	BSC	
н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1.14	1.52	.045	.060	3
ø	0.	10 °	0.	10 °	
ø1	0.	15 '	0.	15°	
ø2	25'	35*	25*	35*	

LEAD	ASSIGNMENTS	

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

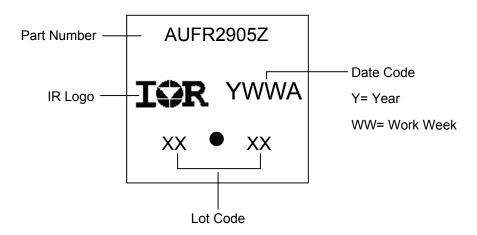
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

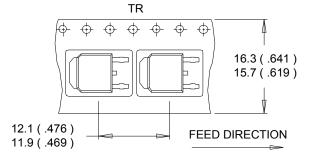
4.- COLLECTOR

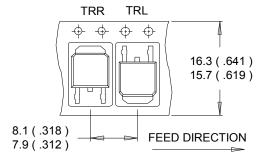
D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

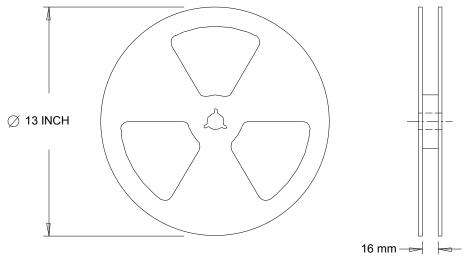
D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES : 1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive (per AEC-Q101)	
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.	
Moisture Sensitivity Level		D-Pak	MSL1
ESD	Machine Model	Class M3 (+/- 400V) [†]	
		AEC-Q101-002	
	Human Body Model		Class H1A (+/- 500V) [†]
		AEC-Q101-001	
	Charged Device Model	Class C5 (+/- 1125V) [†]	
		AEC-Q101-005	
RoHS Compliant		Yes	

† Highest passing voltage.

Revision History

Date	Comments	
10/12/2015	Updated datasheet with corporate template	
10/12/2013	Corrected ordering table on page 1.	

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